

Notice of References Cited	Application/Control No. 10/717,610		Applicant(s)/Patent Under Reexamination DO, GI HYEONG	
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*	A	US-2011/0000100 A1	01-2011	Malcher et al.	34/499
*	B	US-2011/0005339 A1	01-2011	ASHRAFZADEH et al.	73/862.192
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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